

DESCRIPTION

The H11AV series optocoupler consists of an infrared emitting diode optically coupled to an NPN silicon photo transistor in a standard 6 pin dual in line plastic package.

FEATURES

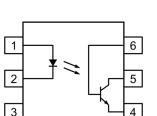
- High AC Isolation Voltage 5000V_{RMS}
- Wide Operating Temperature Range -55°C to 100°C
- RoHS Compliant
- UL Approval E91231 Model "GG"
- VDE Approval 40028086

APPLICATIONS

- Computer Terminals
- Industrial System Controllers
- Measurement Instruments
- Signal Transmission between Systems of Different Potentials and Impedances

ORDER INFORMATION

- Add Suffix "X" for VDE Approval
- Add G after PN for 10mm lead spacing
- Add SM after PN for Surface Mount
- Add SMT&R after PN for Surface Mount Tape & Reel





- 1 Anode
- 2 Cathode
- 3 NC
- 4 Emitter
- 5 Collector
- 6 Base

ABSOLUTE MAXIMUM RATINGS $(T_A = 25^{\circ}C)$

Stresses exceeding the absolute maximum ratings can cause permanent damage to the device.

Exposure to absolute maximum ratings for long periods of time can adversely affect reliability.

Input

Forward Current	60mA
Reverse Voltage	6V
Power Dissipation	105mW
Junction Temperature	125°C

Output

Collector Current	50mA
Collector to Emitter Voltage V _{CEO}	70V
Collector to Base Voltage V_{CBO}	70V
Emitter to Collector Voltage V_{ECO}	6V
Emitter to Base Voltage V _{EBO}	6V
Power Dissipation	160mW

Total Package

Total Power Dissipation	200mW
Isolation Voltage	$5000V_{\text{RMS}}$
Operating Temperature	−55 to 100°C
Storage Temperature	−55 to 125°C
Lead Soldering Temperature (10s)	260°C

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ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise specified)

INPUT

Parameter	Symbol	Test Condition	Min	Тур.	Max	Unit
Forward Voltage	V_{F}	$I_F = 60 \text{mA}$		1.4	1.7	V
Reverse Current	I_R	$V_R = 6V$			10	μΑ
Terminal Capacitance	C_{t}	$V_F = 0V, f = 1kHz$		30	250	pF

OUTPUT

Parameter	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector-Emitter Breakdown Voltage	BV _{CEO}	$I_{C} = 0.1 \text{mA}, I_{F} = 0 \text{mA}$	70			V
Collector-Base Breakdown Voltage	$\mathrm{BV}_{\mathrm{CBO}}$	$I_{C} = 0.1 \text{mA}, I_{F} = 0 \text{mA}$	70			V
Emitter-Collector Breakdown Voltage	$\mathrm{BV}_{\mathrm{ECO}}$	$I_E=10\mu A,I_F=0mA$	6			V
Collector Dark Current	I_{CEO}	$V_{CE} = 10V, I_F = 0mA$			50	nA

COUPLED

Parameter	Symbol	Test Condition	Min	Тур.	Max	Unit
Current transfer ratio	CTR	$I_F = 10 \text{mA}, V_{CE} = 10 \text{V}$				%
		H11AV1	100		300	
		H11AV2	50			
		H11AV3	20			
Collector-Emitter Saturation Voltage	V _{CE(sat)}	$I_F = 10 \text{mA}, I_C = 2.5 \text{mA}$		0.25	0.4	V
Floating Capacitance	C_{f}	$V_{IO} = 0V, f = 1MHz$		0.6	1	pF
Cut-Off Frequency	f_{C}	$V_{CC} = 5V, I_F = 10mA$ $R_L = 75\Omega, -3dB$		150		kHz
Output Rise Time	t _r	$V_{CC} = 5V$, $I_F = 10mA$ $R_L = 75\Omega$		2	7	μs
Output Fall Time	t_{f}			2	8	μs



ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise specified)

ISOLATION

Parameter	Symbol	Test Condition	Min	Тур.	Max	Unit
Isolation Voltage	$V_{\rm ISO}$	R.H. = 40% to 60%, t = 1 min Note 1	5000			V_{RMS}
Isolation Resistance	$R_{\rm ISO}$	$V_{\text{I-O}} = 500 \text{VDC}$ R.H. = 40% to 60% Note 1	5x10 ¹⁰	1x10 ¹¹		Ω

Note 1: Measured with input leads shorted together and output leads shorted together.



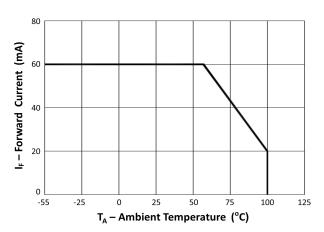


Fig 1 Forward Current vs Ambient Temperature

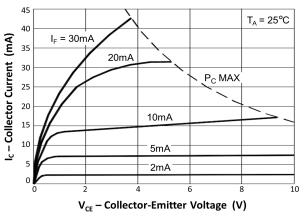


Fig 3 Collector Current vs Collector-Emitter Voltage

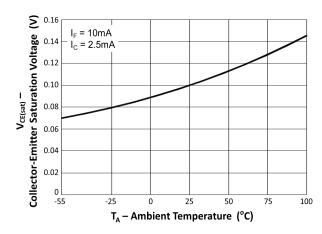


Fig 5 Collector-Emitter Saturation Voltage vs Ambient Temperature

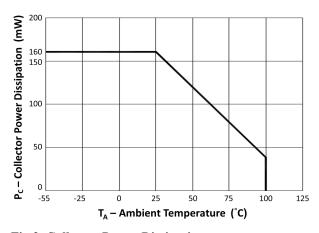


Fig 2 Collector Power Dissipation vs Ambient Temperature

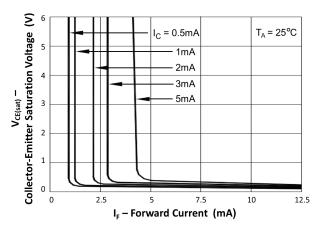


Fig 4 Collector Current vs Collector-Emitter Voltage (2)

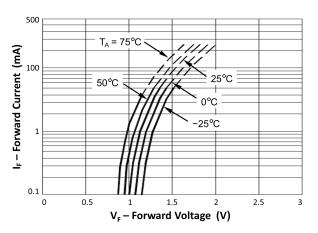


Fig 6 Forward Current vs Forward Voltage



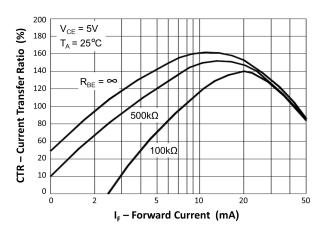


Fig 7 Current Transfer Ratio vs Forward Current

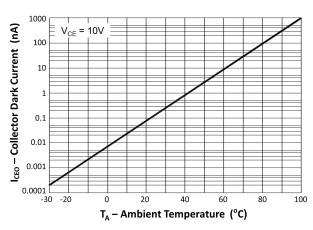


Fig 9 Collector Dark Current vs Ambient Temperature

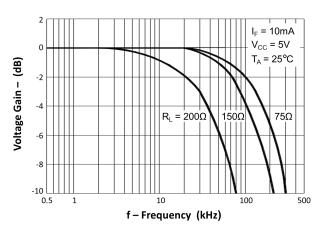


Fig 11 Frequency Response

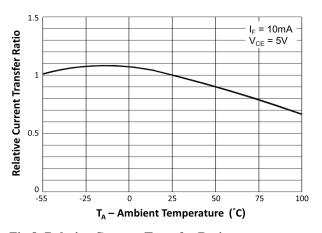


Fig 8 Relative Current Transfer Ratio vs Ambient Temperature

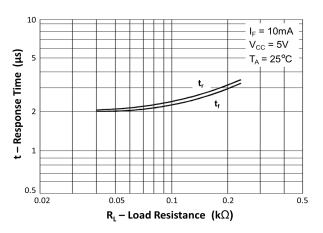
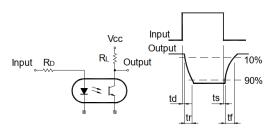
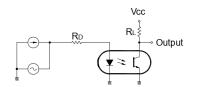


Fig 10 Response Time vs Load Resistance



Response Time Test Circuit



Frequency Response Test Circuit



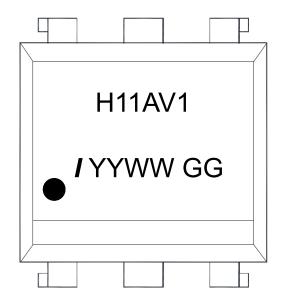
ORDER INFORMATION

	H11AV1, H11AV2, H11AV3 (UL Approval)					
After PN	PN	Description	Packing quantity			
None	H11AV1, H11AV2, H11AV3	Standard DIP6	65 pcs per tube			
G	H11AV1G, H11AV2G, H11AV3G	10mm Lead Spacing	65 pcs per tube			
SM	H11AV1SM, H11AV2SM, H11AV3SM	Surface Mount	65 pcs per tube			
SMT&R	H11AV1SMT&R H11AV2SMT&R H11AV3SMT&R	Surface Mount Tape and Reel	1000 pcs per reel			

H11AV1X, H11AV2X, H11AV3X (UL and VDE Approvals)					
After PN	PN	Description	Packing quantity		
None	H11AV1X, H11AV2X, H11AV3X	Standard DIP6	65 pcs per tube		
G	H11AV1XG, H11AV2XG, H11AV3XG	10mm Lead Spacing	65 pcs per tube		
SM	H11AV1XSM H11AV2XSM H11AV3XSM	Surface Mount	65 pcs per tube		
SMT&R	H11AV1XSMT&R H11AV2XSMT&R H11AV3XSMT&R	Surface Mount Tape and Reel	1000 pcs per reel		



DEVICE MARKING Example: H11AV1



H11AV1 Device Part Number

I Isocom

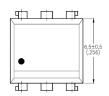
YY 2 digit Year Code WW 2 digit Week Code

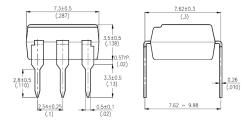
GG UL Model



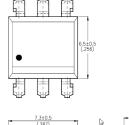
PACKAGE DIMENSIONS in mm (inch)

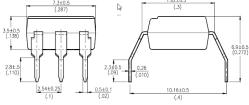
DIP



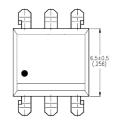


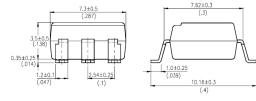
G Form





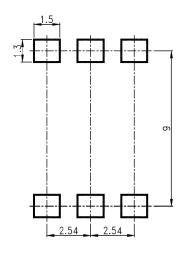
Surface Mount



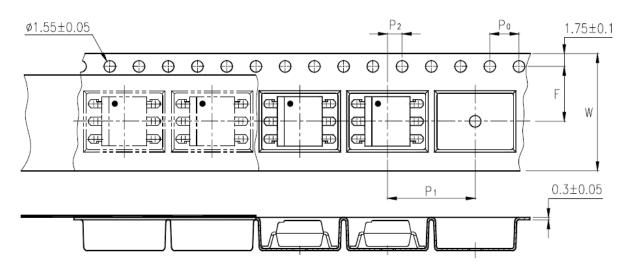




RECOMMENDED SOLDER PAD LAYOUT (mm)



TAPE AND REEL PACKAGING

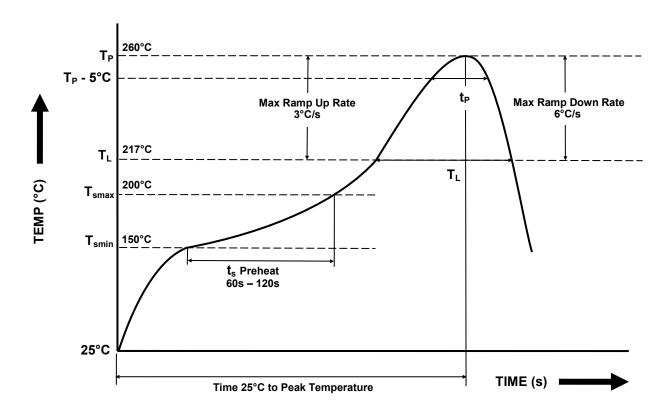


Description	Symbol	Dimension mm (inch)
Tape Width	W	16 ± 0.3 (0.63)
Pitch of Sprocket Holes	P ₀	4 ± 0.1 (0.15)
Distance of Compartment to Sprocket Holes	F	7.5 ± 0.1 (0.295)
Distance of Compartment to Sprocket Holes	P ₂	2 ± 0.1 (0.079)
Distance of Compartment to Compartment	P ₁	12 ± 0.1 (0.472)



IR REFLOW SOLDERING TEMPERATURE PROFILE

One Time Reflow Soldering is Recommended. Do not immerse device body in solder paste.



Profile Details	Conditions
Preheat - Min Temperature (T _{SMIN}) - Max Temperature (T _{SMAX}) - Time T _{SMIN} to T _{SMAX} (t _s)	150°C 200°C 60s - 120s
$\begin{tabular}{lll} \textbf{Soldering Zone} \\ - & \text{Peak Temperature } (T_P) \\ - & \text{Time at Peak Temperature} \\ - & \text{Liquidous Temperature } (T_L) \\ - & \text{Time within } 5^{\circ}\text{C of Actual Peak Temperature } (T_P - 5^{\circ}\text{C}) \\ - & \text{Time maintained above } T_L \ (t_L) \\ - & \text{Ramp Up Rate } (T_L \ to \ T_P) \\ - & \text{Ramp Down Rate } (T_P \ to \ T_L) \\ \end{tabular}$	260°C 10s max 217°C 30s max 60s - 100s 3°C/s max 6°C/s max
Average Ramp Up Rate (T _{smax} to T _P)	3°C/s max
Time 25°C to Peak Temperature	8 minutes max



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